Description

The VSM75N20 uses advanced trench technology and design to provide excellent $R_{DS(ON)}$ with low gate charge. It can be used in automotive applications and a wide variety of other applications.

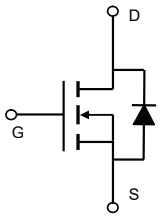
General Features

- V_{DSS} =200V,I_D =75A
  $R_{DS(ON)}$ < 22mΩ @ V_{GS}=10V
- Good stability and uniformity with high E_{AS}
- Special process technology for high ESD capability
- High density cell design for ultra low Rdson
- Fully characterized avalanche voltage and current
- Excellent package for good heat dissipation

Application

- Automotive applications
- Hard switched and high frequency circuits
- Uninterruptible power supply

TO-263



Schematic

Package Marking and Ordering Information

Device Marking	Device	Device Package	Reel Size	Tape width	Quantity
VSM75N20	VSM75N20-T3	TO-263	-	-	-

Absolute Maximum Ratings (T_C=25℃unless otherwise noted)

Parameter	Symbol	Limit	Unit
Drain-Source Voltage	V_{DSS}	200	V
Gate-Source Voltage	V_{GS}	±20	V
Drain Current-Continuous	I_D	75	A
Drain Current-Continuous(T_C=100℃)	I_D (100℃)	53	A
Pulsed Drain Current (Note 1)	I_{DM}	300	A
Maximum Power Dissipation	P_D	360	W
Derating factor		2.4	W/℃
Single pulse avalanche energy (Note 3)	E_{AS}	600	mJ
Operating Junction and Storage Temperature Range	T_J,T_{STG}	-55 To 175	℃

Thermal Characteristic

Thermal Resistance,Junction-to-Case (Note 1)	$R_{\theta JC}$	0.42	℃/W

Electrical Characteristics (T_C=25℃unless otherwise noted)

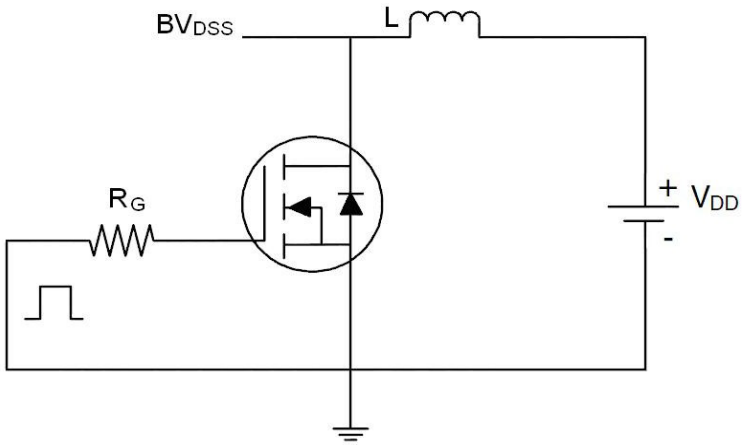
Parameter	Symbol	Condition	Min	Typ	Max	Unit
Off Characteristics						
Drain-Source Breakdown Voltage	BV_{DSS}	V_{GS}=0V I_D=250μA	200	-	-	V
Zero Gate Voltage Drain Current	I_{DSS}	V_{DS}=200V,V_{GS}=0V	-	-	1	μA
Gate-Body Leakage Current	I_{GSS}	V_{GS}=±20V,V_{DS}=0V	-	-	±100	nA
On Characteristics						
Gate Threshold Voltage	$V_{GS(th)}$	V_{DS}=V_{GS},I_D=250μA	2	3	4	V
Drain-Source On-State Resistance	$R_{DS(ON)}$	V_{GS}=10V, I_D=40A	-	19	22	mΩ
Forward Transconductance	g_{FS}	V_{DS}=20V,I_D=40A	-	115	-	S
Dynamic Characteristics						
Input Capacitance	C_{lss}	V_{DS}=100V,V_{GS}=0V, F=1.0MHz	-	8238	-	PF
Output Capacitance	C_{oss}		-	275	-	PF
Reverse Transfer Capacitance	C_{rss}		-	112	-	PF
Switching Characteristics						
Turn-on Delay Time	$t_{d(on)}$	V_{DD}=100V,I_D=40A, V_{GS}=10V,R_G=2.7Ω	-	17	-	nS
Turn-on Rise Time	t_r		-	18	-	nS
Turn-Off Delay Time	$t_{d(off)}$		-	56	-	nS
Turn-Off Fall Time	t_f		-	22	-	nS
Total Gate Charge	Q_g	ID=40A,VDD=100V,VGS=10V	-	152.7	-	nC
Gate-Source Charge	Q_{gs}		-	44.5	-	nC
Gate-Drain Charge	Q_{gd}		-	47.9	-	nC
Drain-Source Diode Characteristics						
Diode Forward Voltage	V_{SD}	V_{GS}=0V,I_S=75A	-	-	1.2	V
Reverse Recovery Time	t_{rr}	TJ = 25°C, IF = 40A di/dt = 100A/μs(Note2)	-	136	-	nS
Reverse Recovery Charge	Qrr		-	458	-	nC

Notes:

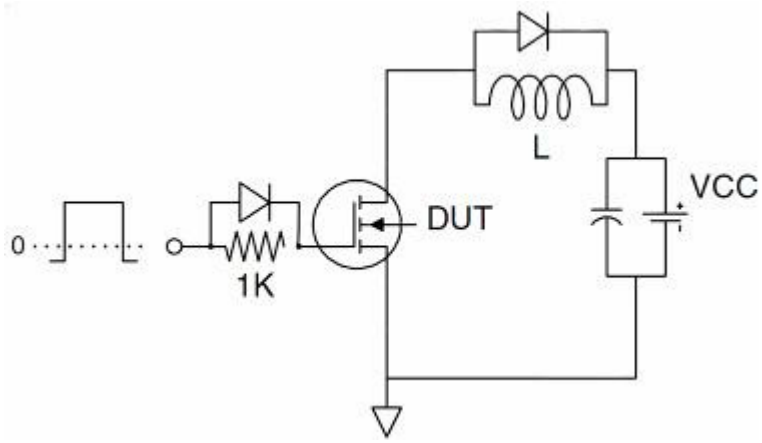
1. Surface Mounted on FR4 Board, t ≤ 10 sec.
2. Pulse Test: Pulse Width ≤ 400μs, Duty Cycle ≤ 2%.
3. EAS condition：Tj=25℃,V_{DD}=50V,V_G=10V,L=1mH,Rg=25Ω

Test Circuit

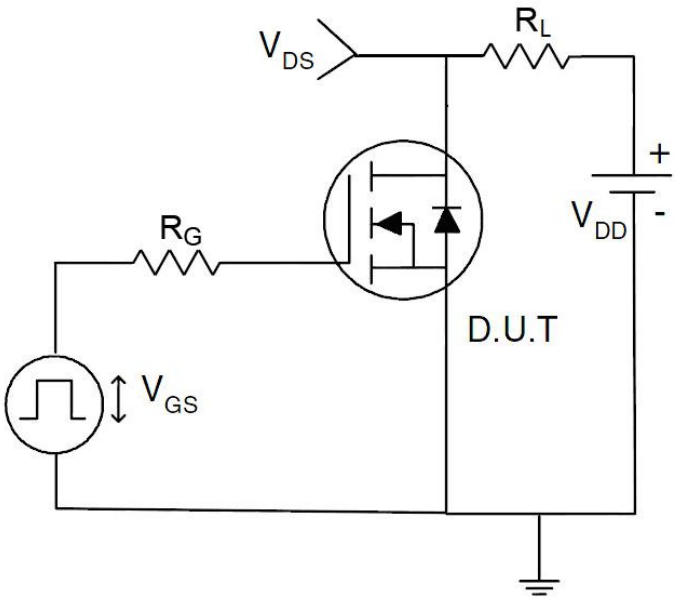
1） E_{AS} test Circuit



2） Gate charge test Circuit



3） Switch Time Test Circuit



Typical Electrical and Thermal Characteristics(Curves)

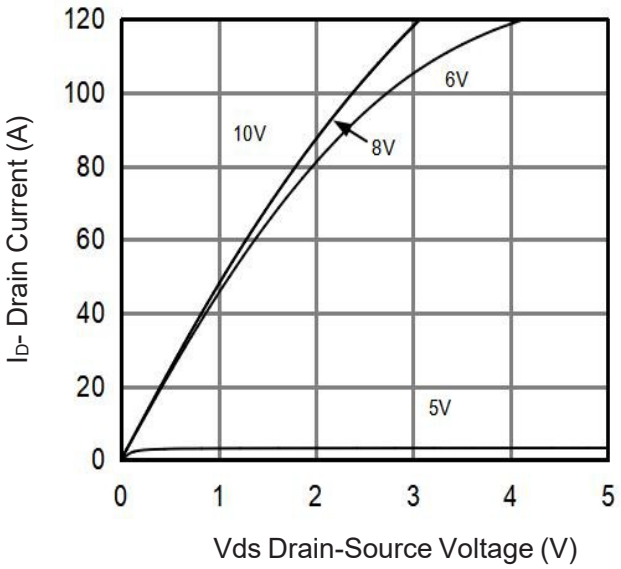


Figure 1 Output Characteristics

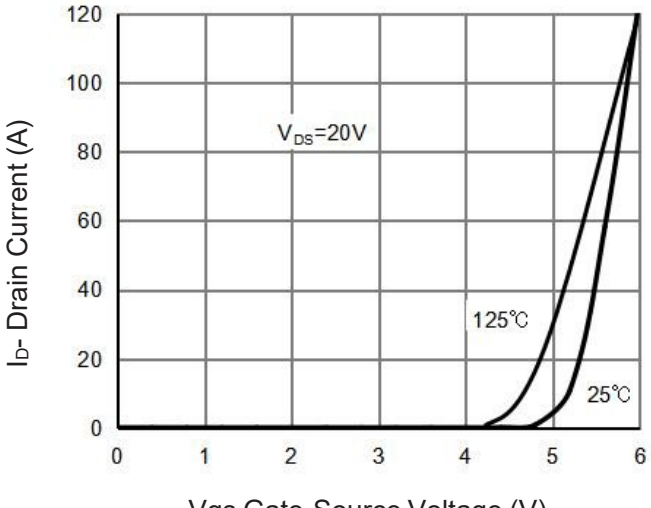


Figure 2 Transfer Characteristics

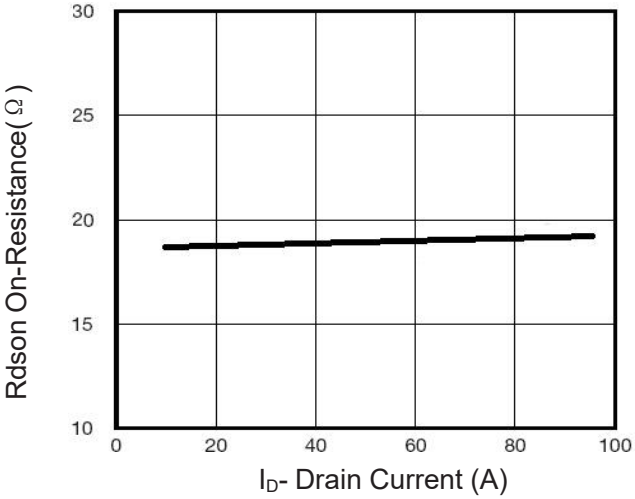


Figure 3 Rdson- Drain Current

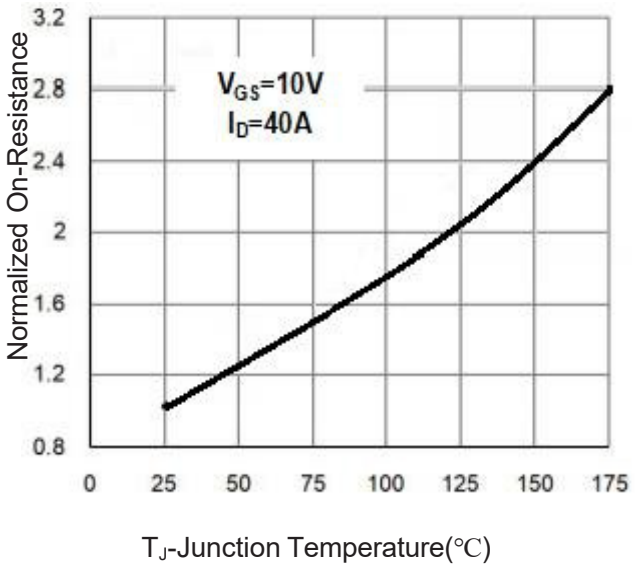


Figure 4 Rdson-JunctionTemperature

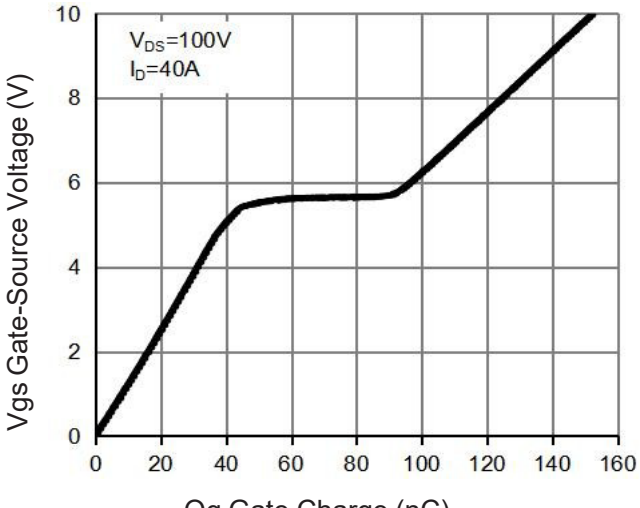


Figure 5 Gate Charge

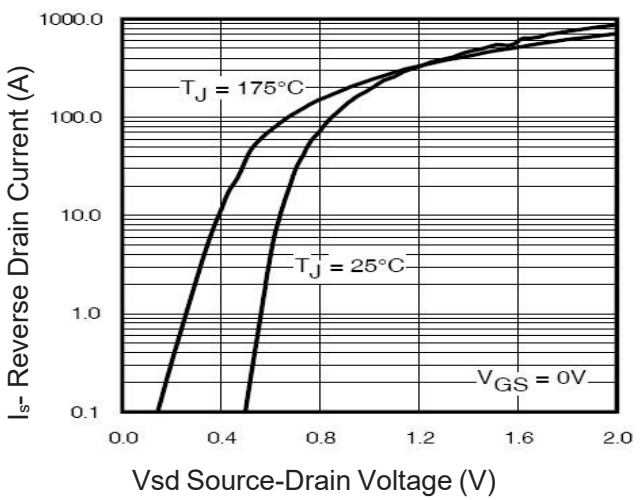


Figure 6 Source- Drain Diode Forward

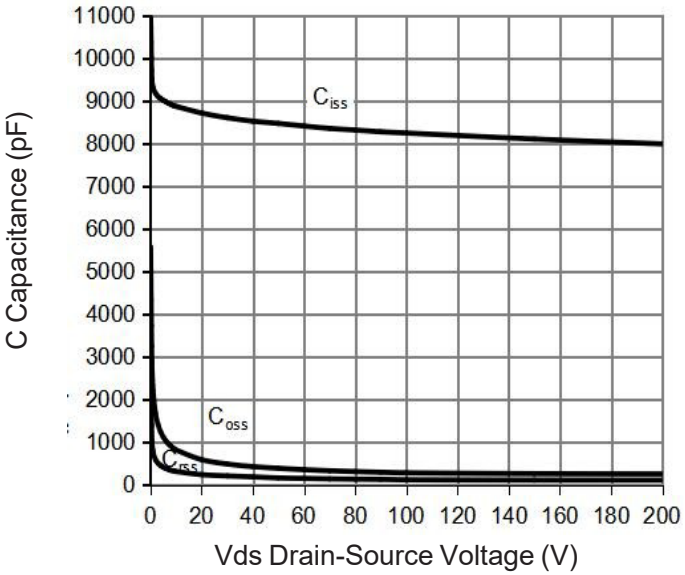


Figure 7 Capacitance vs Vds

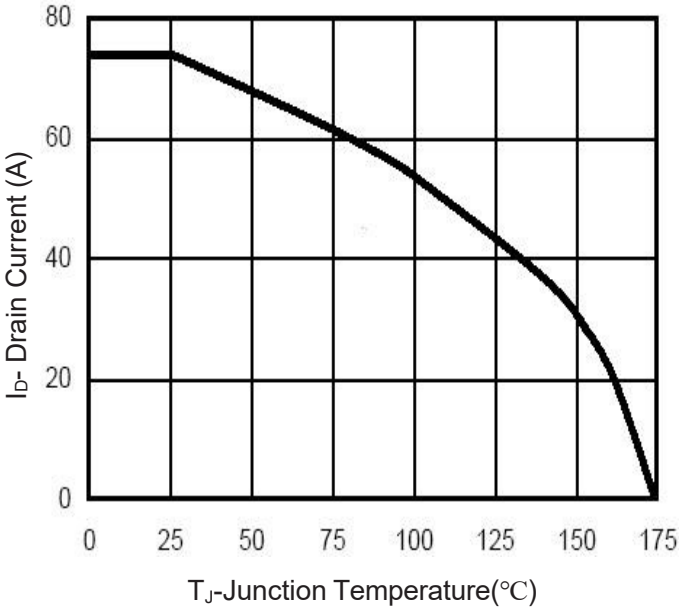


Figure 9 Current De-rating

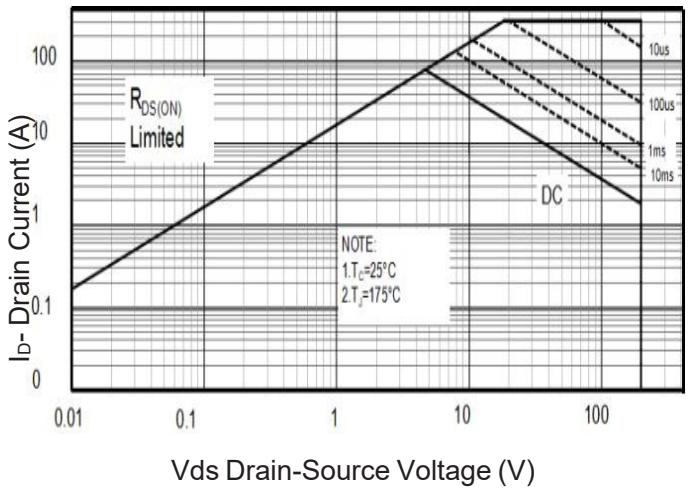


Figure 8 Safe Operation Area

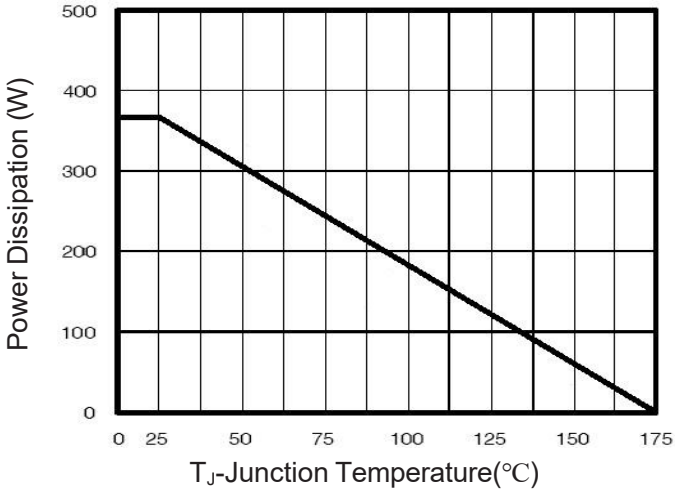


Figure 10 Power De-rating

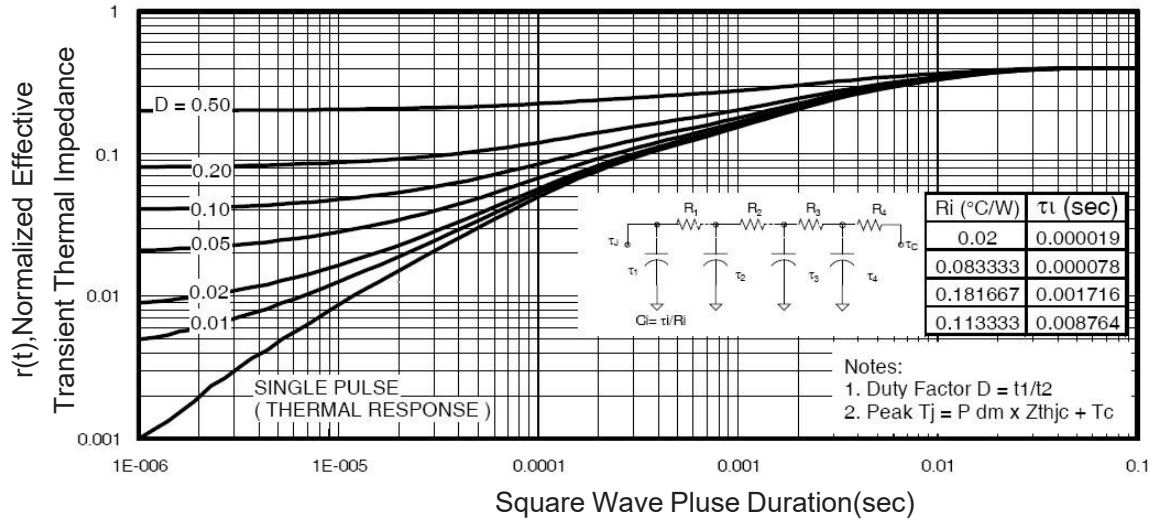


Figure 11 Normalized Maximum Transient Thermal Impedance